## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10517513	TJIA ET AL.
Examiner	Art Unit
BAYMOND PHAN	2111

SEARCHED					
Class	Subclass	Date	Examiner		
710	305-315,2-17,36-38,60-61	3/10/08	RP		

SEARCH NOTES				
Search Notes	Date	Examiner		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
710	315,313,33,60-61	3/17/08	RP		

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